IN THE CLAIMS:

Cancel claims 1-13, and add claims 14-25 as shown on the following pages.

- 1. (Cancelled).
- 2. (Cancelled).
- (Cancelled).
- 4. (Cancelled).
- 5. (Cancelled).
- 6. (Cancelled).
- 7. (Cancelled).
- 8. (Cancelled).
- 9. (Cancelled).
- 10. (Cancelled).
- 11. (Cancelled).
- 12. (Cancelled).
- 13. (Cancelled).

14. (New). A system for maintaining an IC-module near a set-point temperature while electrical power dissipation in said IC-module is varied; said system being comprised of:

a container having an open end with a seal for pressing against said IC-module;

at least one nozzle, in said container, for spraying a liquid coolant on said IC-module when said seal is pressed against said IC-module;

a pressure reducing means, coupled to said container, for producing a sub-atmospheric pressure between said container and said IC-module when said seal is pressed against said IC-module; and,

said pressure reducing means including a pressure regulating means for maintaining said sub-atmospheric pressure such that the boiling point of said liquid coolant is lower by at least 10°C from its boiling point at atmospheric pressure, while the temperature of said IC-module is kept near said set-point.

- 15. (New). A system according to claim 14 wherein said pressure reducing means reduces said sub-atmospheric pressure to a point where essentially all of said liquid coolant from each nozzle rapidly vaporizes when it hits said IC-module.
- 16. (New). A system according to claim 15 which further includes a circulation subsystem, coupled to each nozzle, that holds said liquid coolant; and wherein said liquid coolant consists essentially of water.
- 17. (New). A system according to claim 15 which includes multiple nozzles at spaced-apart locations in said container, and each nozzle includes a means for receiving one control signal and a means for ejecting just a single droplet of said liquid coolant when it receives said one control signal.
- 18. (New). A system according to claim 17 which further includes a closed-loop control means for: a) receiving a sensor signal representing a sensed temperature of said IC-module, and b) sending said control signal to all of said nozzles simultaneously with a frequency that increases as the differences between said sensed temperature and said set-point increases.

- 19. (New). A system according to claim 17 which further includes a closed-loop control means for: a) receiving a sensor signal representing a sensed temperature of said IC-module, b) sending said control signal to a subset of said nozzles simultaneously, and c) increasing the number of nozzles in said subset as the difference between said sensed temperature and said set-point increase.
- 20. (New). A system according to claim 17 wherein said means for ejecting in each nozzle ejects said single droplet by squeezing said coolant with a piezoelectric device.
- 21. (New). A system according to claim 17 wherein said means for ejecting in each nozzle ejects said single droplet by heating said coolant with an electric heater.
- 22. (New). A system according to claim 15 wherein each nozzle includes a means for receiving one control signal and a means for spraying multiple droplets of said liquid coolant when it receives said one control signal.

- 23. (New). A system according to claim 22 which further includes a closed-loop control means for: a) receiving a sensor signal representing a sensed temperature of said IC-module, and b) sending said control signal with an ON-OFF ratio that increases as the difference between said sensed temperature and said set-point increases.
- 24. (New). A system according to claim 15 wherein said seal is shaped to encircle a surface on said IC-module which encloses an IC-chip.
- 25. (New). A system according to claim 15 wherein said seal is shaped to encircle an exposed surface on an IC-chip in said IC-module.